## Notice of References Cited Application/Control No. 10/663,568 Examiner Humera N. Sheikh Applicant(s)/Patent Under Reexamination WU ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,464,650	11-1995	Berg et al.	
	В	US-			<del></del>
	С	US-			
	۵	US-			
	ш	US-			
	F	US-			
	G	US-			
	Ι	US-			
		US-			
	7	US-			
	К	US-			
	L.	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	01/01890 A1	01-2001	WO	Yang et al.	
	0					
	Ρ					
	Q					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)							
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